

### General Description

The AO4478 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge. This device is suitable for use as general purpose, PWM and a load switch applications.

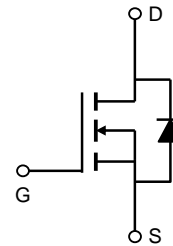
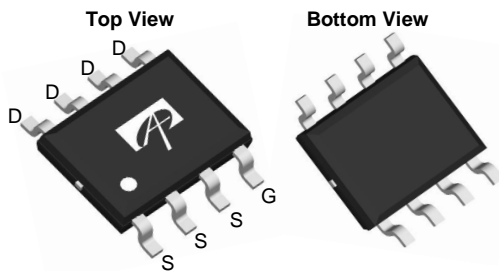
### Product Summary

$V_{DS} (V) = 30V$   
 $I_D = 9A (V_{GS} = 10V)$   
 $R_{DS(ON)} < 19m\Omega (V_{GS} = 10V)$   
 $R_{DS(ON)} < 26m\Omega (V_{GS} = 4.5V)$

100% UIS Tested  
 100% Rg Tested



SOIC-8



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                               | Symbol         | Maximum          | Units      |
|---|----------------|------------------|------------|
| Drain-Source Voltage                    | $V_{DS}$       | 30               | V          |
| Gate-Source Voltage                     | $V_{GS}$       | $\pm 25$         | V          |
| Continuous Drain Current                | $I_D$          | $T_A=25^\circ C$ | 9.0        |
|   |                | $T_A=70^\circ C$ | 7.0        |
| Pulsed Drain Current <sup>C</sup>       | $I_{DM}$       | 60               | A          |
| Avalanche Current <sup>C</sup>          | $I_{AR}$       | 17               |            |
| Repetitive avalanche energy $L=0.1mH^C$ | $E_{AR}$       | 14               | mJ         |
| Power Dissipation <sup>B</sup>          | $P_D$          | $T_A=25^\circ C$ | 3.1        |
|   |                | $T_A=70^\circ C$ | 2.0        |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$ | -55 to 150       | $^\circ C$ |

### Thermal Characteristics

| Parameter                                 | Symbol          | Typ          | Max | Units        |
|---|-----------------|--------------|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup>  | $R_{\theta JA}$ | 31           | 40  | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>AD</sup> |                 | Steady-State | 59  | 75           |
| Maximum Junction-to-Lead <sup>C</sup>     | $R_{\theta JL}$ | 16           | 24  | $^\circ C/W$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min | Typ      | Max      | Units |
|-----------------------------|---------------------------------------|--|-----|----------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |          |          |       |
| B <sub>V</sub> DSS          | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V   | 30  |          |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |     |          | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±25V  |     |          | 100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =250μA                                     | 1   | 1.6      | 2        | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V  | 60  |          |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =9A<br>T <sub>J</sub> =125°C                          |     | 16<br>25 | 19<br>30 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =8A  |     | 21       | 26       | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =10A   |     | 24       |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V  |     | 0.70     | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |  |     |          | 4        | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |          |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz  |     | 466      | 560      | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |  |     | 90       |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |  |     | 61       |          | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz   |     | 3.7      | 5.6      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |          |          |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =9A                             |     | 9.3      | 11       | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |  |     | 4.3      | 5.2      | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |  |     | 1        |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |  |     | 2.3      |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =1.65Ω,<br>R <sub>GEN</sub> =3Ω |     | 5        |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |  |     | 8        |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |  |     | 20       |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |  |     | 5        |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =9A, di/dt=500A/μs  |     | 7.5      | 9        | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =9A, di/dt=500A/μs  |     | 9.8      |          | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using ≤ 10s junction-to-ambient thermal resistance.

C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

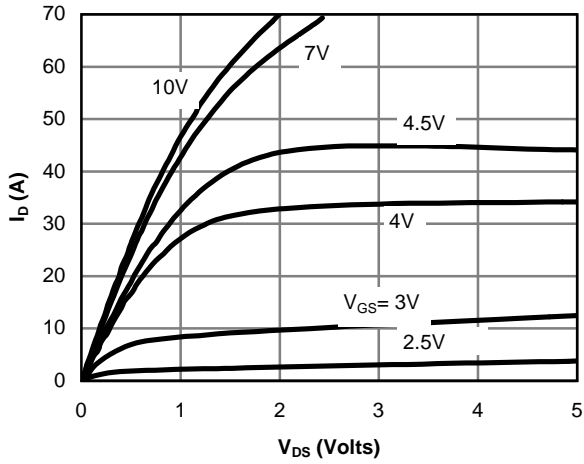
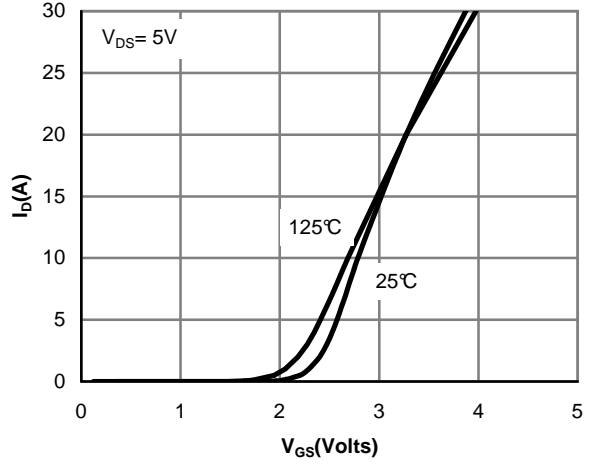
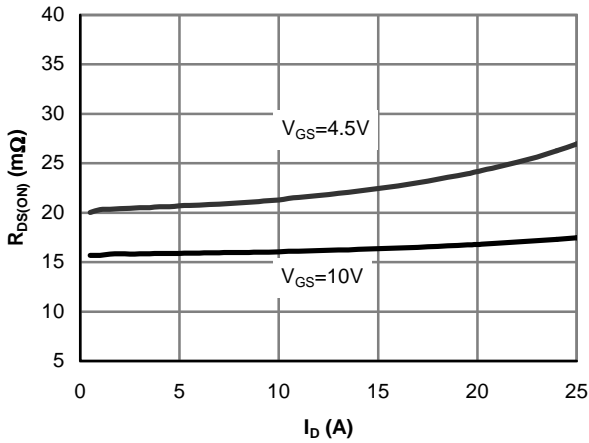
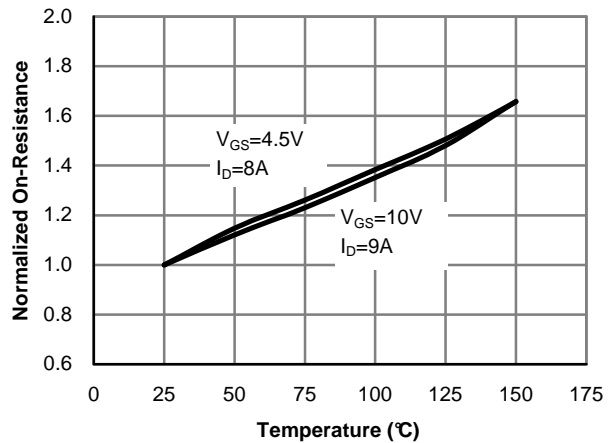
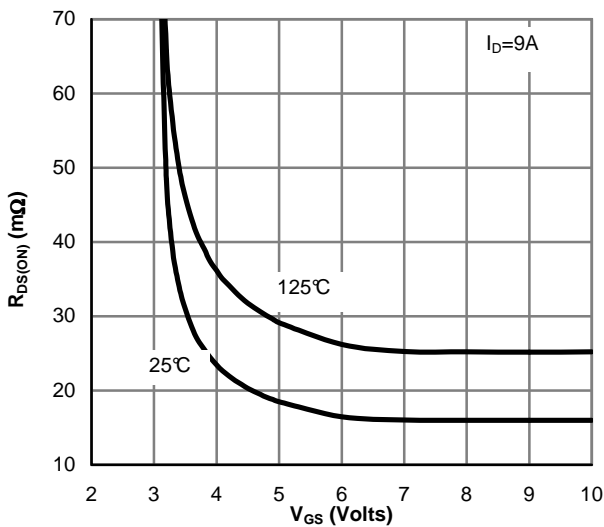
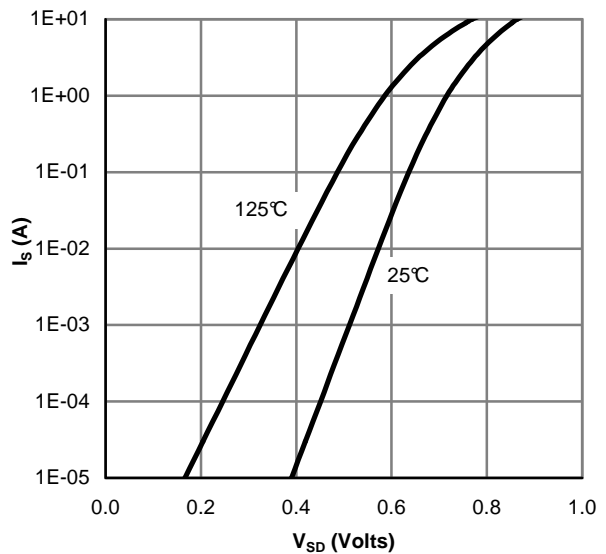
D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

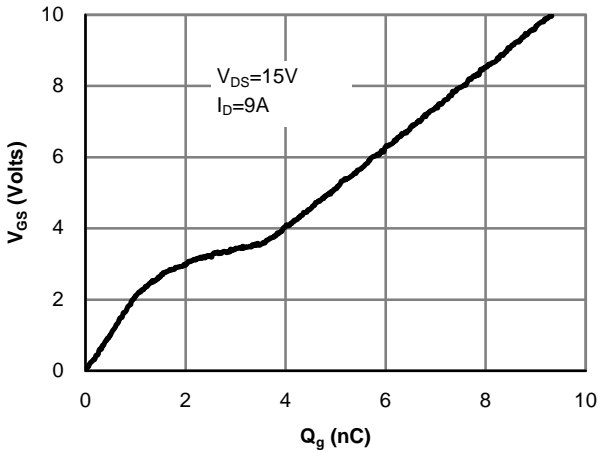
F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.

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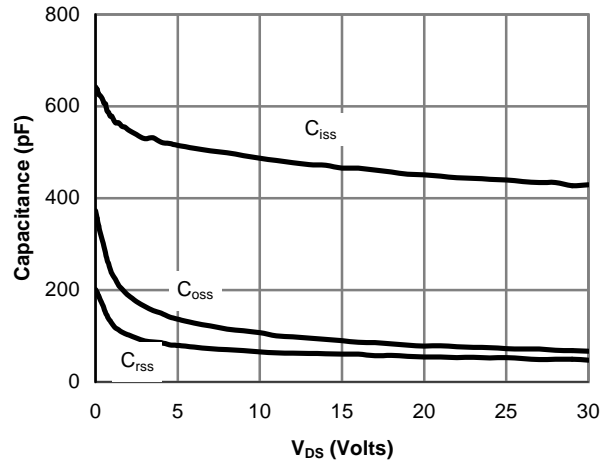
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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 1: On-Region Characteristics(Note E)**

**Figure 2: Transfer Characteristics(Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage(Note E)**

**Figure 4: On-Resistance vs. Junction Temperature(Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage(Note E)**

**Figure 6: Body-Diode Characteristics(Note E)**

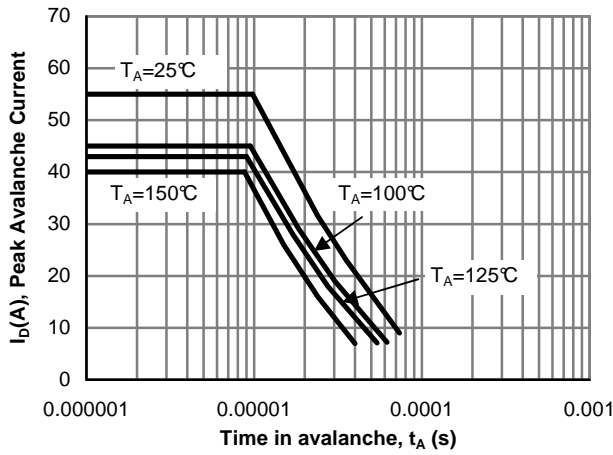
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



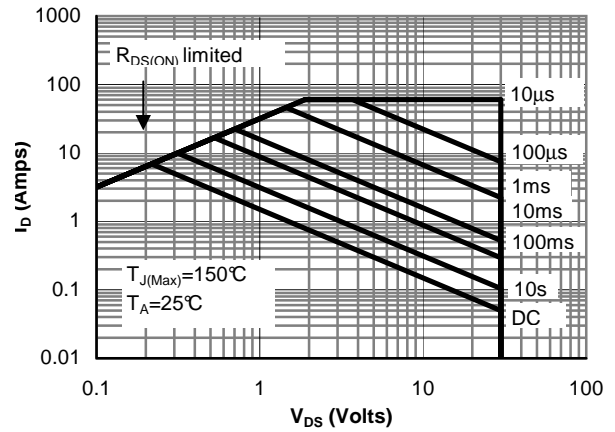
**Figure 7: Gate-Charge Characteristics**



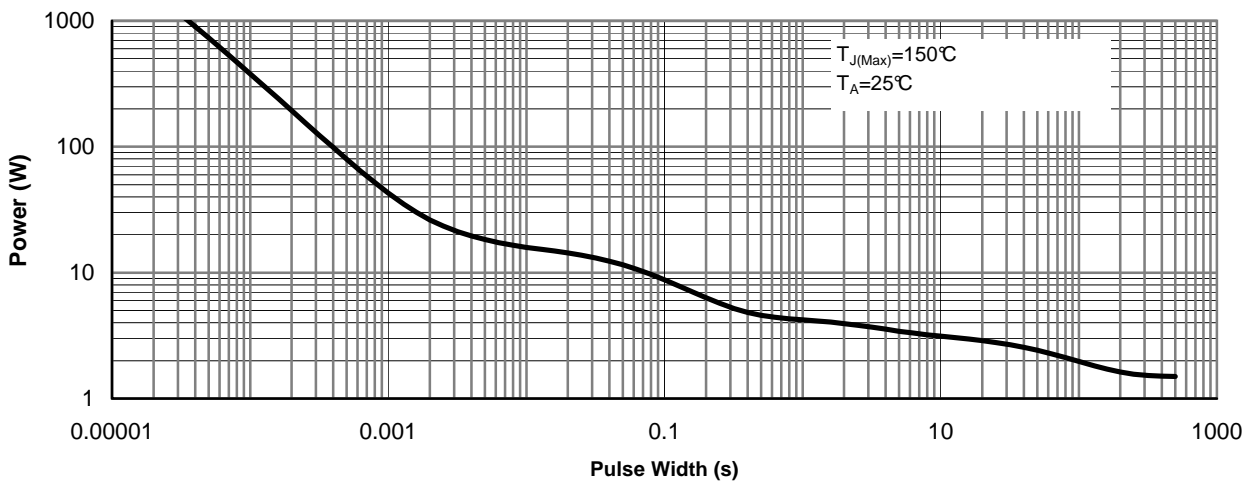
**Figure 8: Capacitance Characteristics**



**Figure 9: Single Pulse Avalanche capability (Note C)**

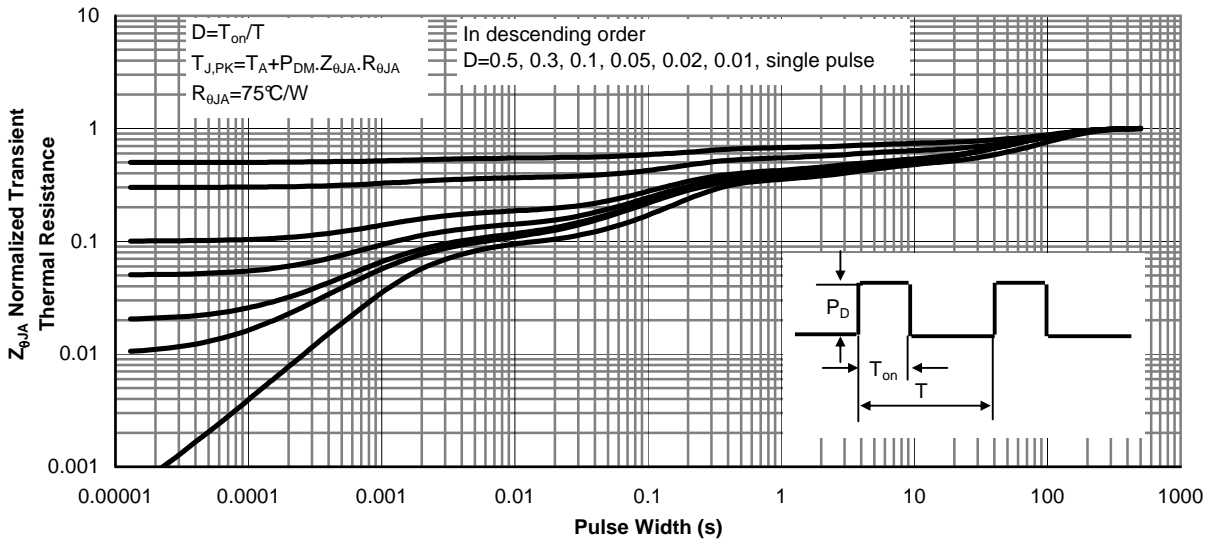


**Figure 10: Maximum Forward Biased Safe Operating Area (Note F)**



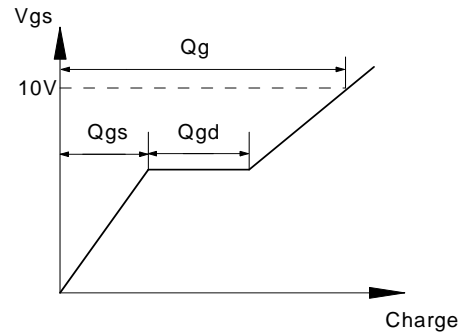
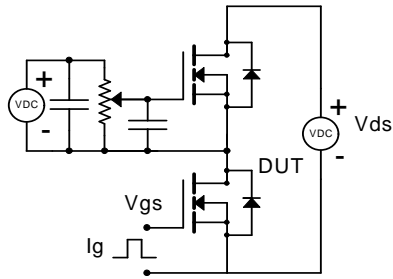
**Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

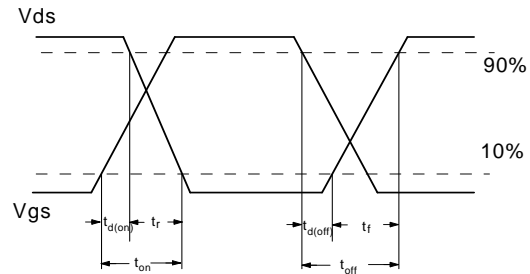
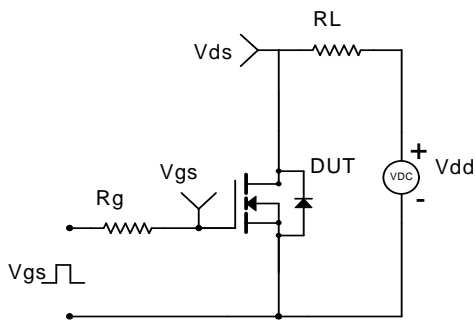


**Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)**

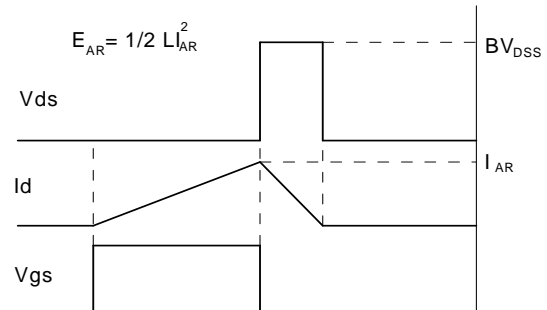
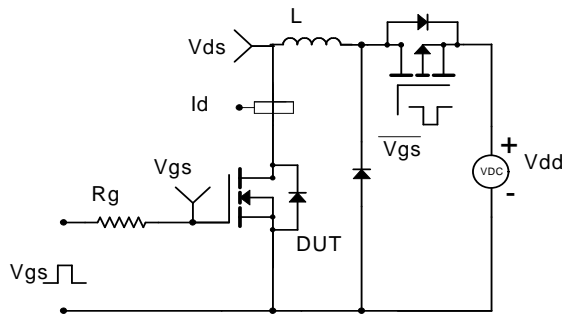
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

